<u>Voltage Regulator</u> -Low-Dropout

150 mA

The NCV4299C is a family of precision micropower voltage regulators with an output current capability of 150 mA. It is available in 5.0 V or 3.3 V output voltage.

The output voltage is accurate within $\pm 2\%$ with a maximum dropout voltage of 0.5 V at 100 mA. Low Quiescent current is a feature drawing only 80 μ A with a 100 μ A load. This part is ideal for any and all battery operated microprocessor equipment.

The device features microprocessor interfaces including an adjustable reset output and adjustable system monitor to provide shutdown early warning. An inhibit function is available. With inhibit active, the regulator turns off and the device consumes less than $1.0 \,\mu\text{A}$ of quiescent current.

The part can withstand load dump transients making it suitable for use in automotive environments.

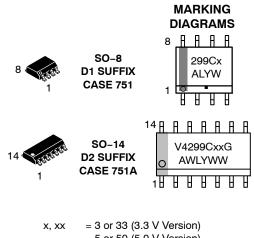
Features

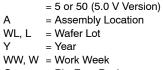
- 5.0 V, 3.3 V ±2%, 150 mA
- Extremely Low Current Consumption
 - 80 µA (Typ) in the ON Mode
 - $< 1.0 \,\mu\text{A}$ in the Off Mode
- Early Warning
- Reset Output Low Down to $V_0 = 1.0 V$
- Adjustable Reset Threshold
- Wide Temperature Range
- Fault Protection
 - 60 V Peak Transient Voltage
 - → -40 V Reverse Voltage
 - Short Circuit
 - Thermal Overload
- Internally Fused Leads on SO-14 Package
- $\bullet\,$ Inhibit Function with 1 μA Current Consumption in the Off Mode
- AEC-Q100 Grade 1 Qualified and PPAP Capable
- These are Pb-Free Devices



ON Semiconductor®

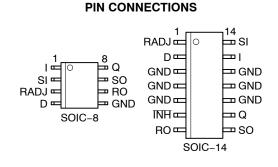
www.onsemi.com





G or • = Pb-Free Package

(Note: Microdot may be in either location)



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 17 of this data sheet.

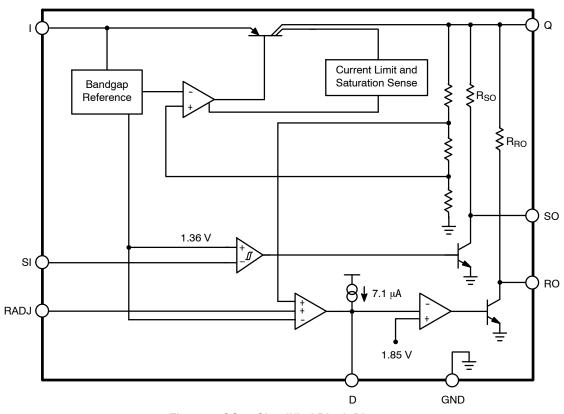
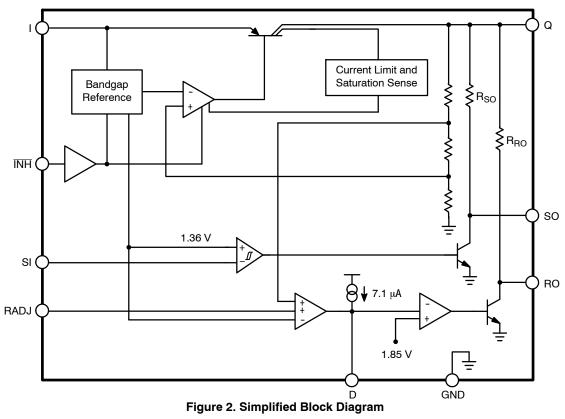


Figure 1. SO-8 Simplified Block Diagram

PIN FUNCTION DESCRIPTION - SO-8 PACKAGE

Pin	Symbol	Description
1	I	Input. Battery Supply Input Voltage. Bypass directly to GND with ceramic capacitor.
2	SI	Sense Input. Can provide an early warning signal of an impending reset condition when used with SO. Connect to Q if not used.
3	RADJ	Reset Adjust. Use resistor divider to Q to adjust reset threshold lower. Connect to GND if not used.
4	D	Reset Delay. Connect external capacitor to ground to set delay time.
5	GND	Ground.
6	RO	Reset Output. NPN collector output with internal 20 k Ω pullup to Q. Notifies user of out of regulation condition. Leave open if not used.
7	SO	Sense Output. NPN collector output with internal 20 k Ω pullup to Q. Can be used to provide early warning of an impending reset condition. Leave open if not used.
8	Q	5.0 V, 3.3 V, ±2%, 150 mA output. Use 22 $\mu\text{F},$ ESR $<$ 4 Ω to ground.



PIN FUNCTION DESCRIPTION

Pin No. SOIC-14	Symbol	Description
1	RADJ	Reset Adjust. Use resistor divider to Q to adjust reset threshold lower. Connect to GND if not used.
2	D	Reset Delay. Connect external capacitor to ground to set delay time.
3	GND	Ground
4	GND	Ground
5	GND	Ground
6	INH	Inhibit. Connect to I if not needed. A high turns the regulator on. Use a low pass filter if transients with slew rate in excess of 10 V/ μ s may be present on this pin during operation. See Figure 34 for details.
7	RO	Reset Output. NPN collector output with internal 20 k Ω pullup to Q. Notifies user of out of regulation condition.
8	SO	Sense Output. NPN collector output with internal 20 k Ω pullup to Q. Can be used to provide early warning of an impending reset condition.
9	Q	5.0 V, 3.3 V, $\pm 2\%$ 150 mA output. Use 22 μF ESR $<$ 4 Ω to ground.
10	GND	Ground
11	GND	Ground
12	GND	Ground
13	ļ	Input. Battery Supply Input Voltage.
14	SI	Sense Input. Can provide an early warning signal of an impending reset condition when used with SO.

MAXIMUM RATINGS

Rating	Symbol	Min	Мах	Unit
Input Voltage to Regulator (DC)	VI	-40	45	V
Input Peak Transient Voltage to Regulator wrt GND (Note 1)	-	-	60	V
Inhibit (INH)	VINH	-40	45	V
Sense Input (SI)	V _{SI}	-40	45	V
Sense Input (SI)	I _{SI}	-1.0	1.0	mA
Reset Threshold (RADJ)	V _{RADJ}	-0.3	7.0	V
Reset Threshold (RADJ)	I _{RADJ}	-10	10	mA
Reset Delay (D)	VD	-0.3	7.0	V
Reset Output (RO)	V _{RO}	-0.3	7.0	V
Reset Output (RO)	I _{RO}	-20	20	mA
Sense Output (SO)	V _{SO}	-0.3	7.0	V
Output (Q)	V _Q	-0.3	16	V
Output (Q)	۱ _Q	-5.0	-	mA
ESD Capability, Human Body Model (Note 3)	ESD _{HB}	2.0	-	kV
ESD Capability, Machine Model (Note 3)	ESD _{MM}	200	-	V
ESD Capability, Charged Device Model (Note 3)	ESD _{CDM}	1.0	-	kV
Junction Temperature	TJ	_	150	°C
Storage Temperature	T _{stg}	-50	150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

RECOMMENDED OPERATING RANGE

Input Voltage	5.0 V Version 3.3 V Version	VI	5.5 4.4	45 45	V
Junction Temperature		TJ	-40	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

LEAD TEMPERATURE SOLDERING REFLOW (Note 2)

Reflow (SMD styles only), lead free 60 s-150 sec above 217, 40 sec max at	peak	T _{SLD}	-	265 Pk	°C
Moisture Sensitivity Level	SO-8 SO-14	MSL	Lev Lev		

1. Load Dump Test B (with centralized load dump suppression) according to ISO16750-2 standard. Guaranteed by design. Not tested in production. Passed Class C according to ISO16750-1 2. Per IPC / JEDEC J-STD-020C.

3. This device series incorporates ESD protection and is tested by the following methods:

ESD HBM tested per AEC-Q100-002 (JS-001-2010)

ESD MM tested per AEC-Q100-003 (ÈIA/JESD22-A115)

ESD CDM tested per AEC-Q100-011 (EIA/JESD22-C101).

THERMAL CHARACTERISTICS

		Test Co			
Charao	teristic	Note 4	Note 5	Note 6	Unit
Thermal Characteristics, SO-8	$\begin{array}{l} Junction-to-Lead \; (\psi_{JLx}, \; \theta_{JLx}) \\ Junction-to-Ambient \; (R_{\theta JA}, \; \theta_{JA}) \end{array}$	72 198	58 150.7	58.3 124.5	°C/W
Thermal Characteristics, SO-14	Junction–to–Lead (ψ_{JLx} , θ_{JLx}) Junction–to–Ambient ($R_{\theta JA}$, θ_{JA})	15.1 142.7	19.9 101.2	19.3 86.1	°C/W
Thermal Characteristics, TSSOP-1-	4 EP Junction-to-Tab (ψ _{JLx} , θ _{JLx}) Junction-to-Ambient (R _{θJA} , θ _{JA})	9.7 111.6	11.4 78.7	11.7 53.7	°C/W

4. 2 oz Copper, 50 mm sq Copper area, 1.5 mm thick FR4.

5. 2 oz Copper, 150 mm sq Copper area, 1.5 mm thick FR4.

6. 2 oz Copper, 500 mm sq Copper area, 1.5 mm thick FR4.

ELECTRICAL CHARACTERISTICS ($-40^{\circ}C < T_J < 150^{\circ}C$; V_I = 13.5 V unless otherwise noted.)

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
Ουτρυτ Q				-		
Output Voltage (5.0 V Version)	V _Q	1.0 mA < I_Q < 150 mA, 6.0 V < V_I < 16 V	4.9	5.0	5.1	V
Output Voltage (3.3 V Version)	V _Q	1.0 mA < I _Q < 150 mA, 5.5 V < V _I < 16 V	3.23	3.3	3.37	V
Current Limit	lQ	$V_Q = 90\%$ of V_{Qnom}	250	430	500	mA
Quiescent Current (I _q = I _I – I _Q)	۱ _q	$\overline{\rm INH}$ ON, I _Q < 100 μ A, T _J = 25°C	-	80	90	μA
Quiescent Current (I _q = I _I – I _Q)	۱ _q	\overline{INH} ON, I_Q < 100 $\mu A,T_J$ \leq 125°C	-	80	95	μA
Quiescent Current (I _q = I _I – I _Q)	۱ _q	ĪNĦ ON, I _Q = 10 mA	-	200	500	μA
Quiescent Current (I _q = I _I – I _Q)	۱ _q	ĪNĦ ON, I _Q = 50 mA	-	0.8	2.0	mA
Quiescent Current (I _q = I _I – I _Q)	۱ _q	$\overline{\text{INH}} = 0 \text{ V}, \text{ T}_{\text{J}} = 25^{\circ}\text{C}$	-	-	1.0	μA
Dropout Voltage (Note 7)	V _{dr}	I _Q = 100 mA	-	0.26	0.50	V
Load Regulation	ΔV_Q	I _Q = 1.0 mA to 100 mA	-	1.0	30	mV
Line Regulation	ΔV_Q	$V_{I} = 6.0 \text{ V to } 28 \text{ V}, I_{Q} = 1.0 \text{ mA}$	-	2.0	25	mV
Power Supply Ripple Rejection	PSRR	<i>f</i> r = 100 Hz, Vr = 1.0 Vpp, I _Q = 100 mA	-	66	-	dB
INHIBIT (INH)						
Inhibit Off Voltage	VINHOFF	V _Q < 0.1 V	-	-	0.8	V
Inhibit On Voltage 5.0 V Version 3.3 V Version	VINHON	V _Q > 4.9 V V _Q > 3.23 V	3.5 3.5		- -	V
Input Current		INH = 5 V INH = 0 V	-	3.8 0.01	10 2.0	μΑ
RESET (RO)						
Switching Threshold 5.0 V Version 3.3 V Version	V _{RT}	-	4.50 2.96	4.67 3.07	4.80 3.16	V
Output Resistance	R _{RO}	-	10	20	40	kΩ
Reset Output Low Voltage 5.0 V Version 3.3 V Version	V _{RO}	V_Q = 4.5 V, Internal R_{RO},I_{RO} = –1.0 mA V_Q = 2.96 V, Internal R_{RO},I_{RO} = –1.0 mA		0.05 0.05	0.40 0.40	V
Allowable External Reset Pullup Resistor	V _{ROext}	External Resistor to Q	5.6	-	-	kΩ
Delay Upper Threshold	V _{UD}	-	1.5	1.85	2.2	V
Delay Lower Threshold	V _{LD}	-	0.4	0.5	0.6	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 7. Only for 5 V version. Measured when the output voltage V_Q has dropped 100 mV from the nominal value obtained at $V_I = 13.5$ V.

ELECTRICAL CHARACTERISTICS	(continued) (-40°C	< T _J < 150°C; V	I = 13.5 V unless otherwise noted.)
-----------------------------------	--------------------	-----------------------------	-------------------------------------

Characteristic	Symbol	Test Conditions	Min	Тур	Max	Unit
RESET (RO)						
Delay Output Low Voltage 5.0 V Version 3.3 V Version	V _{D,sat}	V _Q = 4.5 V, Internal R _{RO} V _Q = 2.96 V, Internal R _{RO}		_ 0.017	0.1 0.1	V
Delay Charge Current	Ι _D	V _D = 1.0 V	4.0	7.1	12	μΑ
Power On Reset Delay Time	t _d	C _D = 100 nF	17	28	35	ms
Reset Reaction Time	t _{RR}	C _D = 100 nF	0.5	1.6	4.0	μs
Reset Adjust Switching Threshold 5.0 V Version 3.3 V Version	V _{RADJ,TH}	V _Q = 3.5 V V _Q = 2.3 V	1.26 1.26	1.36 1.36	1.44 1.44	V
INPUT VOLTAGE SENSE (SI and SO)						
Sense Input Threshold High	V _{SI,High}	-	1.34	1.45	1.54	V
Sense Input Threshold Low	V _{SI,Low}	-	1.26	1.36	1.44	V

V _{SI,Low}	-	1.26	1.36	1.44	V
-	(Sense Threshold High) – (Sense Threshold Low)	50	90	130	mV
I _{SI}	V _{SI} = 1.2 V	-1.0	0.1	1.0	μA
R _{SO}	-	10	20	40	kΩ
V _{SO}	V_{SI} = 1.2 V, V_{I} = 5.5 V, I_{SO} = 0 μA	-	0.1	0.4	V
R _{SOext}	-	5.6	-	-	kΩ
t _{PSOLH}	$R_{SOext} = 5.6 \text{ k}\Omega$	-	1.3	8.0	μs
t _{PSOHL}	R _{SOext} = 5.6 kΩ	-	2.2	5.0	μs
	I _{SI} R _{SO} V _{SO} R _{SOext} t _{PSOLH}	$\begin{tabular}{ c c c c } \hline & & & & & & & & & & & & & & & & & & $	$\begin{tabular}{ c c c c c } \hline & & & & & & & & & & & & & & & & & & $	- (Sense Threshold High) - (Sense Threshold Low) 50 90 I_{SI} $V_{SI} = 1.2 V$ -1.0 0.1 R_{SO} - 10 20 V_{SO} $V_{SI} = 1.2 V$, $V_I = 5.5 V$, $I_{SO} = 0 \mu A$ - 0.1 R_{SOext} - 5.6 - t_{PSOLH} $R_{SOext} = 5.6 k\Omega$ - 1.3	- (Sense Threshold High) - (Sense Threshold Low) 50 90 130 I_{SI} $V_{SI} = 1.2 V$ -1.0 0.1 1.0 R_{SO} - 10 20 40 V_{SO} $V_{SI} = 1.2 V$, $V_I = 5.5 V$, $I_{SO} = 0 \mu A$ - 0.1 0.4 R_{SOext} - 5.6 - - - t_{PSOLH} $R_{SOext} = 5.6 k\Omega$ - 1.3 8.0

THERMAL SHUTDOWN

Thermal Shutdown Temperature (Note 8)	T _{SD}	l _{out} = 1 mA	150	-	200	°C
Q Values based on design and/or observatori	ation.					

8. Values based on design and/or characterization.

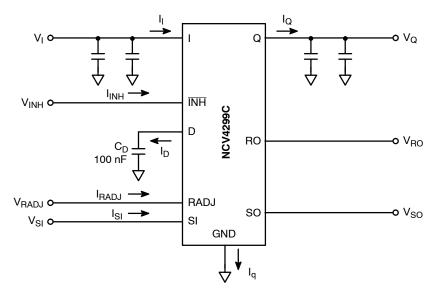
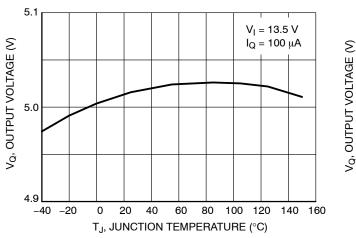


Figure 3. Measurement Circuit

TYPICAL PERFORMANCE CHARACTERISTICS – 5.0 V OPTION





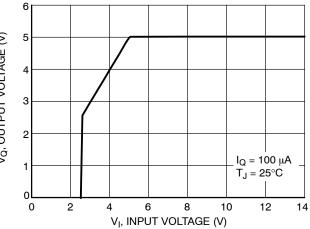
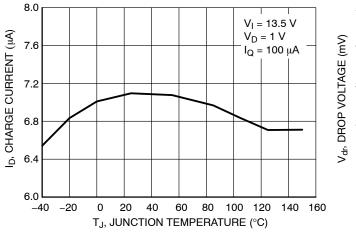


Figure 5. Output Voltage vs. Input Voltage





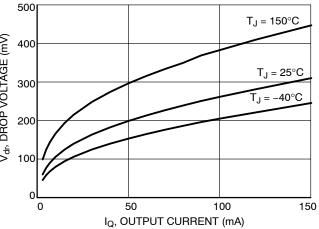
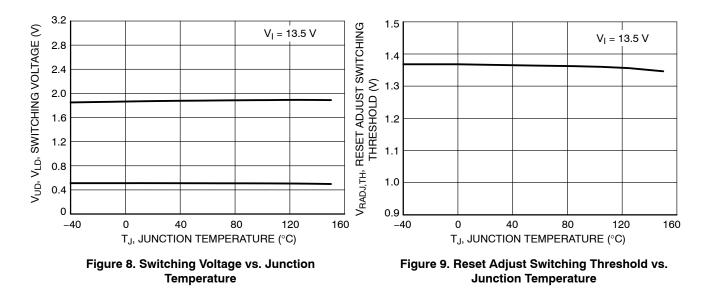
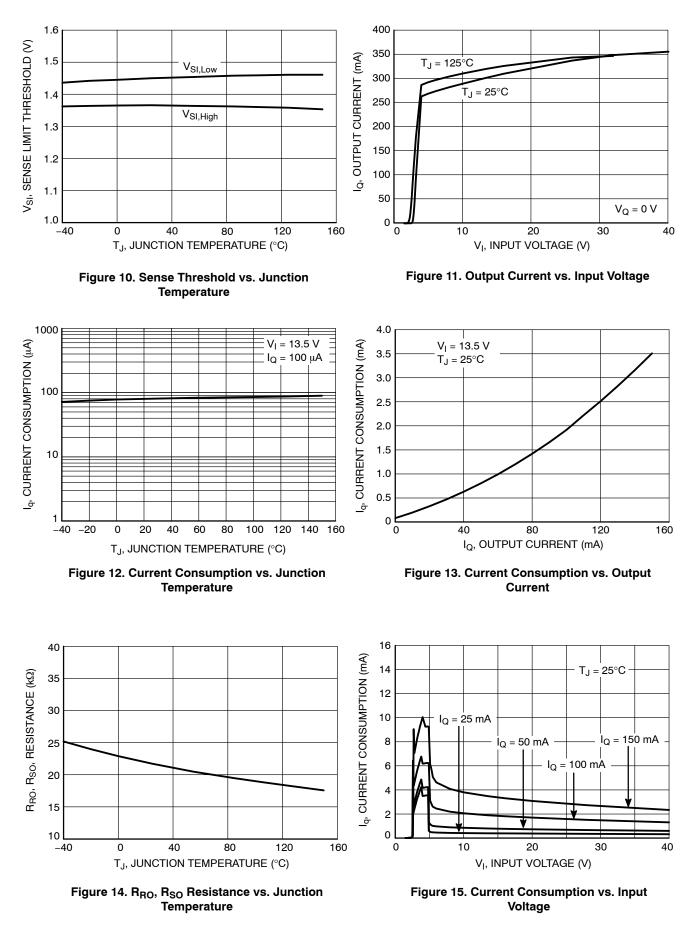
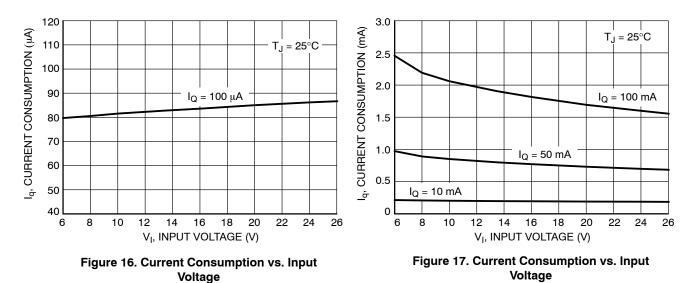


Figure 7. Drop Voltage vs. Output Current







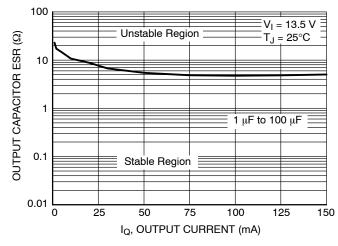
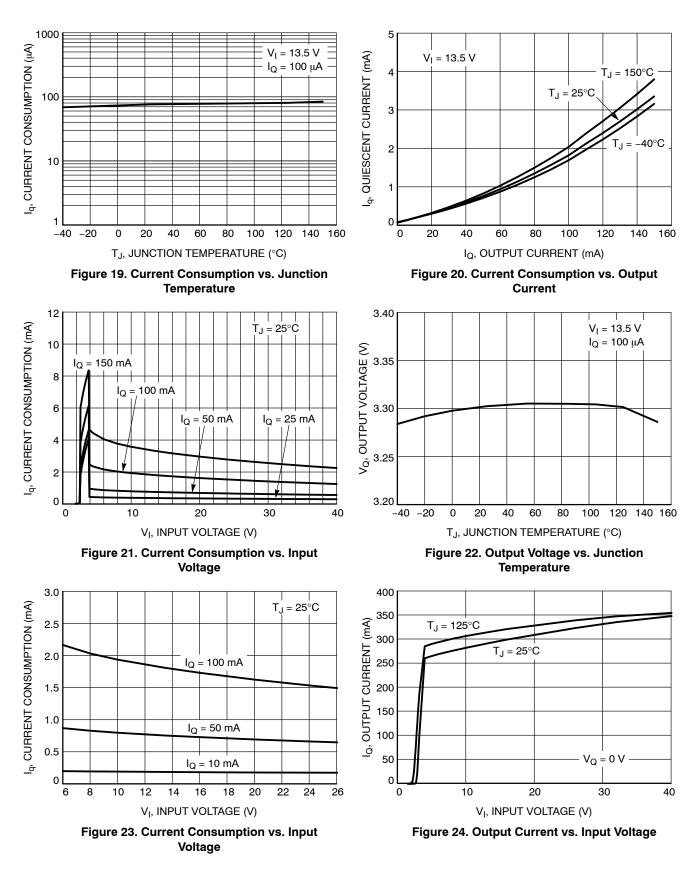
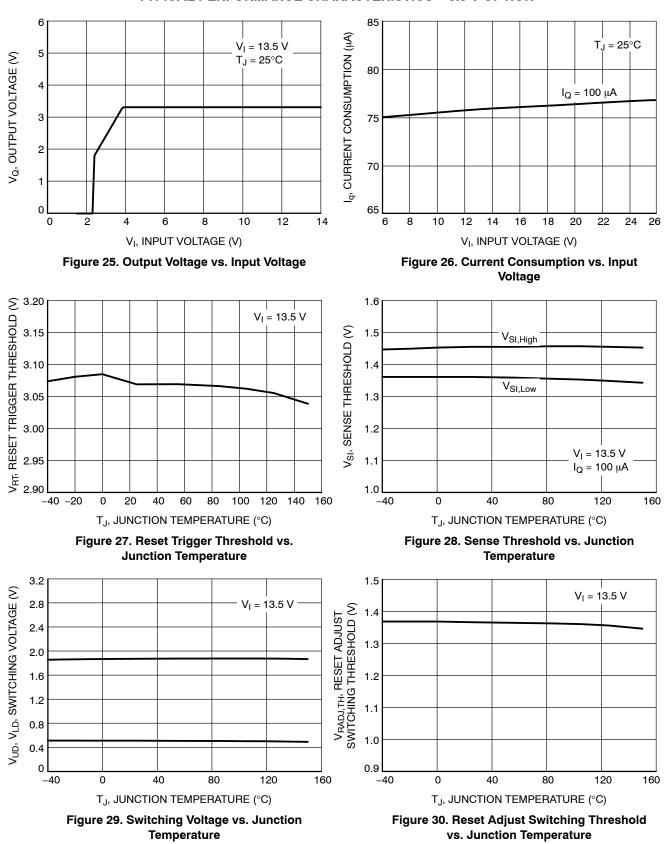


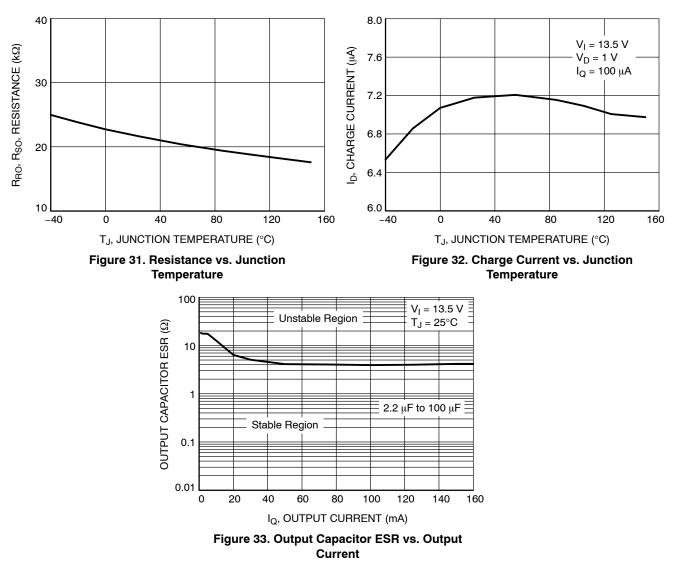
Figure 18. Output Stability vs. Output Capacitor ESR

TYPICAL PERFORMANCE CHARACTERISTICS – 3.3 V OPTION





TYPICAL PERFORMANCE CHARACTERISTICS - 3.3 V OPTION



TYPICAL PERFORMANCE CHARACTERISTICS - 3.3 V OPTION

APPLICATION DESCRIPTION

NCV4299C

The NCV4299C is a family of precision micropower voltage regulators with an output current capability of 150 mA at 5.0 V and 3.3 V.

The output voltage is accurate within $\pm 2\%$ with a maximum dropout voltage of 0.5 V at 100 mA. Low quiescent current is a feature drawing only 80 μ A with a 100 μ A load. This part is ideal for any and all battery operated microprocessor equipment.

Microprocessor control logic includes an active reset output RO (with delay), and a SI/SO monitor which can be used to provide an early warning signal to the microprocessor of a potential impending reset signal. The use of the SI/SO monitor allows the microprocessor to finish any signal processing before the reset shuts the microprocessor down. Internal output resistors on the RO and SO pins pulling up to the output pin Q reduce external component count. An inhibit function is available on the 14–lead part. With inhibit active, the regulator turns off and the device consumes less that 1.0 μ A of quiescent current.

The active reset circuit operates correctly at an output voltage as low as 1.0 V. The reset function is activated during the powerup sequence or during normal operation if the output voltage drops outside the regulation limits.

The reset threshold voltage can be decreased by the connection of an external resistor divider to the RADJ lead. The regulator is protected against reverse battery, short circuit, and thermal overload conditions. The device can withstand load dump transients making it suitable for use in automotive environments.

NCV4299C Circuit Description

The low dropout regulator in the NCV4299C uses a PNP pass transistor to give the lowest possible dropout voltage capability. The current is internally monitored to prevent oversaturation of the device and to limit current during over current conditions. Additional circuitry is provided to protect the device during overtemperature operation.

The regulator provides an output regulated to 2%.

Other features of the regulator include an undervoltage reset function and a sense circuit. The reset function has an adjustable time delay and an adjustable threshold level. The sense circuit trip level is adjustable and can be used as an early warning signal to the controller. An inhibit function that turns off the regulator and reduces the current consumption to less than 1.0 μ A is a feature available in the 14 pin package.

Output Regulator

The output is controlled by a precision trimmed reference. The PNP output has saturation control for regulation while the input voltage is low, preventing oversaturation. Current limit and voltage monitors complement the regulator design to give safe operating signals to the processor and control circuits.

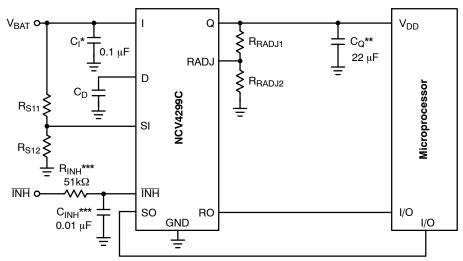
Stability Considerations

The input capacitor C_I is necessary for compensating input line reactance. Possible oscillations caused by input inductance and input capacitance can be damped by using a resistor of approximately 1.0 Ω in series with C_I .

The output or compensation capacitor helps determine three main characteristics of a linear regulator: startup delay, load transient response and loop stability.

The capacitor value and type should be based on cost, availability, size and temperature constraints. A tantalum or aluminum electrolytic capacitor is best, since a film or ceramic capacitor with almost zero ESR can cause instability. The aluminum electrolytic capacitor is the least expensive solution, but, if the circuit operates at low temperatures (-25° C to -40° C), both the value and ESR of the capacitor will vary considerably. The capacitor manufacturer's data sheet usually provides this information.

The value for the output capacitor C_Q shown in Figure 34 should work for most applications, however, it is not necessarily the optimized solution. Stability is guaranteed at values $C_Q \ge 22 \ \mu F$ and an ESR $\le 4 \ \Omega$ within the operating temperature range. Actual limits are shown in a graph in the typical performance characteristics section.

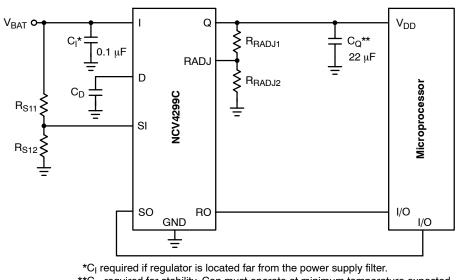


*C₁ required if regulator is located far from the power supply filter.

**C $_{Q}$ required for stability. Cap must operate at minimum temperature expected.

***This RC filter is only required when transients with slew rate in excess of 10 V/ μ s may be present on the \overline{INH} voltage source during operation. The filter is not required when \overline{INH} is connected to a noise-free DC voltage.





**C $_{\rm Q}$ required for stability. Cap must operate at minimum temperature expected.

Figure 35. Test and Application Circuit Showing all Compensation and Sense Elements for 8 Pin Package Part

Reset Output (RO)

A reset signal, Reset Output (RO, low voltage) is generated as the IC powers up. After the output voltage V_Q increases above the reset threshold voltage V_{RT} , the delay timer D is started. When the voltage on the delay timer V_D passes V_{UD} , the reset signal RO goes high. D pin voltage in steady state is typically 2.5 V. A discharge of the delay timer (V_D) is started when V_Q drops and stays below the reset threshold voltage V_{RT} . When the voltage of the delay timer (V_D) drops below the lower threshold voltage V_{LD} , the reset output voltage V_{RO} is brought low to reset the processor.

The reset output RO is an open collector NPN transistor, controlled by a low voltage detection circuit. The circuit is functionally independent of the rest of the IC, thereby guaranteeing that RO is valid for V_Q as low as 1.0 V.

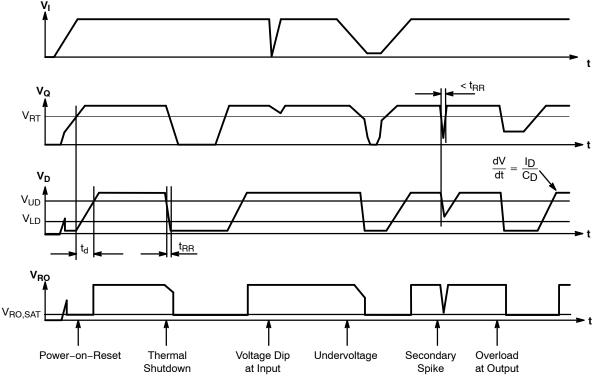


Figure 36. Reset Timing Diagram

Reset Adjust (RADJ)

The reset threshold V_{RT} can be decreased from a typical value of 4.67 V to as low as 3.5 V by using an external voltage divider connected from the Q lead to the pin RADJ, as shown in Figure 34. The resistor divider keeps the voltage above the $V_{RADJ,TH}$, (typ. 1.36 V), for the desired input voltages and overrides the internal threshold detector. Adjust the voltage divider according to the following relationship:

$$VTHRES = VRADJ, TH \cdot (RADJ1 + RADJ2)/RADJ2$$
(eq. 1)

If the reset adjust option is not needed, the RADJ-pin should be connected to GND causing the reset threshold to go to its default value (typ. 4.67 V).

Reset Delay (D)

The reset delay circuit provides a delay (programmable by capacitor C_D) on the reset output RO lead. The delay lead D provides charge current I_D (typically 7.1 μ A) to the external delay capacitor C_D during the following times:

- 1. During Powerup (once the regulation threshold has been exceeded).
- 2. After a reset event has occurred and the device is back in regulation. The delay capacitor is set to discharge when the regulation (V_{RT} , reset threshold voltage) has been violated. When the delay capacitor discharges to down to V_{LD} , the reset signal RO pulls low.

Setting the Delay Time

The delay time is set by the delay capacitor C_D and the charge current I_D . The time is measured by the delay capacitor voltage charging from the low level of $V_{D,sat}$ to the higher level V_{UD} . The time delay follows the equation:

$$t_{d} = [C_{D} (V_{UD} - V_{D, sat})]/I_{D} \qquad (eq. 2)$$

Example:

Using $C_D = 100$ nF. Use the typical value for $V_{D,sat} = 0.1$ V. Use the typical value for $V_{UD} = 1.85$ V. Use the typical value for Delay Charge Current $I_D = 7.1 \mu A$.

$$t_d = [100 \text{ nF}(1.85-0.1 \text{ V})]/7.1 \text{ \mu}\text{A} = 24.6 \text{ ms}$$
 (eq. 3)

When the output voltage V_Q drops below the reset threshold voltage V_{RT} , the voltage on the delay capacitor V_D starts to drop. The time it takes to drop below the lower threshold voltage of V_{LD} is the reset reaction time, t_{RR} . This time is typically 1.6 µs for a delay capacitor of 0.1 µF. The reset reaction time can be estimated from the following relationship:

$$t_{RR} = 16 \text{ ns/nF} \times C_D$$
 (eq. 4)

Sense Input (SI)/Sense Output (SO) Voltage Monitor

An on-chip comparator is available to provide early warning to the microprocessor of a possible reset signal. The reset signal typically turns the microprocessor off instantaneously. This can cause unpredictable results with the microprocessor. The signal received from the SO pin will allow the microprocessor time to complete its present task before shutting down. This function is performed by a comparator referenced to the band gap voltage. The actual trip point can be programmed externally using a resistor divider to the input monitor (SI) (Figure 34). The typical threshold is 1.36 V on the SI Pin.

Signal Output

Figure 37 shows the SO Monitor waveforms as a result of the circuits depicted in Figure 34. As the output voltage V_Q falls, the monitor threshold $V_{SI,Low}$ is crossed. This causes the voltage on the SO output to go low sending a warning signal to the microprocessor that a reset signal may occur in a short period of time. $T_{WARNING}$ is the time the microprocessor has to complete the function it is currently working on and get ready for the reset shutdown signal. When the voltage on the SO goes low and the RO stays high the current consumption is typically 400 μ A.

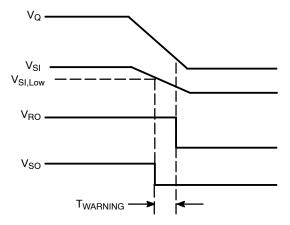
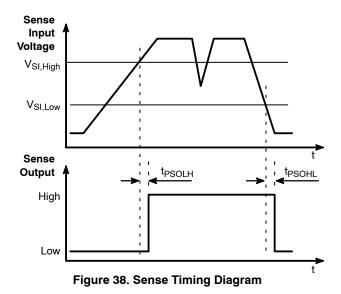


Figure 37. SO Warning Timing Waveform



Calculating Power Dissipation in a Single Output Linear Regulator

The maximum power dissipation for a single output regulator is:

$$P_{D(max)} = [V_{I(max)} - V_{Q(min)}] I_{Q(max)} + V_{I(max)} I_{q}$$
(eq. 5)

where:

V_{I(max)} is the maximum input voltage,

V_{Q(min)} is the minimum output voltage,

 $I_{Q\left(max\right)}$ is the maximum output current for the application, and

 I_q is the quiescent current the regulator consumes at $I_{Q(max)}$.

Once the value of $P_{D(max)}$ is known, the maximum permissible value of R_{0JA} can be calculated:

$$R_{\theta JA} = (150^{\circ} C - T_{A})/P_{D}$$
 (eq. 6)

The value of $R_{\theta JA}$ can then be compared with those in the package section of the data sheet. Those packages with $R_{\theta JA}$'s less than the calculated value in Equation 6 will keep the die temperature below 150°C. In some cases, none of the packages will be sufficient to dissipate the heat generated by the IC, and an external heatsink will be required. Thermal Resistance $R_{\theta JA}$ vs. Copper Area is shown in Figure 39.

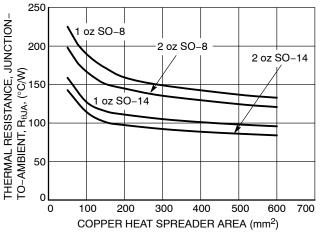


Figure 39. Thermal Resistance $R_{\theta JA}$ vs. Copper Area

Heatsinks

A heatsink effectively increases the surface area of the package to improve the flow of heat away from the IC and into the surrounding air.

Each material in the heat flow path between the IC and the outside environment will have a thermal resistance. Like series electrical resistances, these resistances are summed to determine the value of $R_{\theta IA}$:

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CS} + R_{\theta SA} \qquad (eq. 7)$$

where:

 $R_{\theta JC}$ = the junction-to-case thermal resistance, $R_{\theta CS}$ = the case-to-heatsink thermal resistance, and $R_{\theta SA}$ = the heatsink-to-ambient thermal resistance.

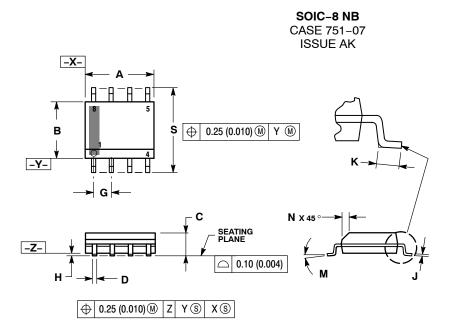
 $R_{\theta JC}$ appears in the package section of the data sheet. Like $R_{\theta JA}$, it too is a function of package type. $R_{\theta CS}$ and $R_{\theta SA}$ are functions of the package type, heatsink and the interface between them. These values appear in heatsink data sheets of heatsink manufacturers. Thermal, mounting, and heatsinking are discussed in the ON Semiconductor application note AN1040/D, available on the ON Semiconductor website.

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV4299CD133R2G	SO-8 (Pb-Free)	2500 / Tape & Reel
NCV4299CD150R2G	SO-8 (Pb-Free)	2500 / Tape & Reel
NCV4299CD233R2G	SO-14 (Pb-Free)	2500 / Tape & Reel
NCV4299CD250R2G	SO-14 (Pb-Free)	2500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

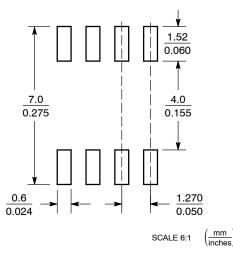
PACKAGE DIMENSIONS

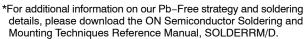


- NOTES: 1. DIMENSIONING AND TOLERANCING PER
- 2.
- З.
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE. 4.
- PER SIDE. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07. 5.
- 6.

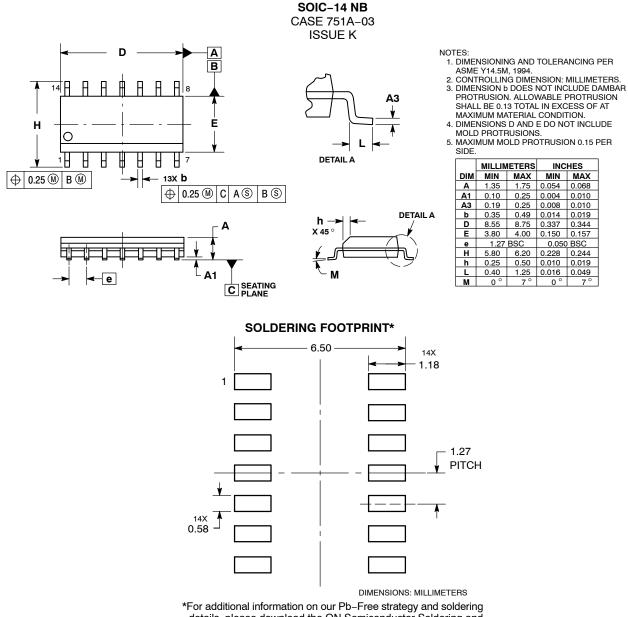
	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
Н	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
κ	0.40	1.27	0.016	0.050
М	0 °	8 °	0 °	8 °
Ν	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

SOLDERING FOOTPRINT*





PACKAGE DIMENSIONS



details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and the an ergistered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or ma

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

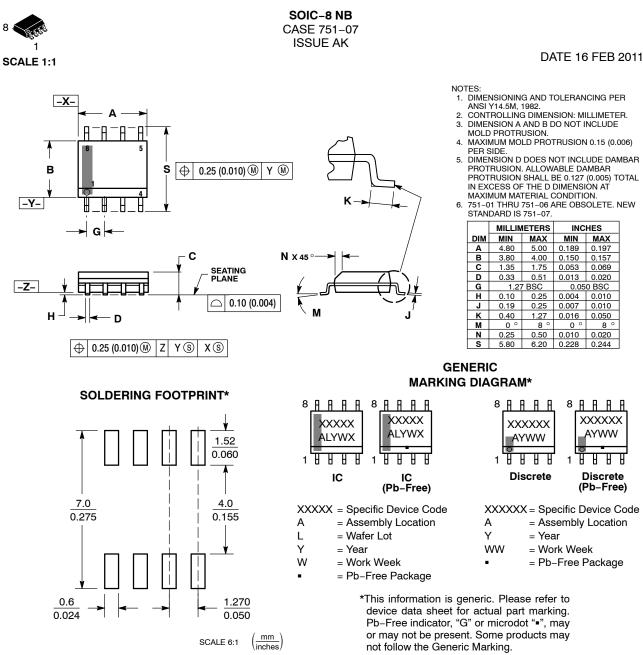
Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

onsemí



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

STYLES ON PAGE 2

DOCUMENT NUMBER:	98ASB42564B	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	SOIC-8 NB		PAGE 1 OF 2	
onsemi and ONSEMi are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.				

SOIC-8 NB CASE 751-07 **ISSUE AK**

STYLE 1: PIN 1. EMITTER COLLECTOR 2. 3. COLLECTOR 4. EMITTER 5. EMITTER BASE 6. 7 BASE EMITTER 8. STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN DRAIN 4. GATE 5. 6. GATE SOURCE 7. 8. SOURCE STYLE 9: PIN 1. EMITTER, COMMON COLLECTOR, DIE #1 COLLECTOR, DIE #2 2. З. EMITTER, COMMON 4. 5. EMITTER, COMMON 6 BASE. DIE #2 BASE, DIE #1 7. 8. EMITTER, COMMON STYLE 13: PIN 1. N.C. 2. SOURCE 3 GATE 4. 5. DRAIN 6. DRAIN DRAIN 7. DRAIN 8. STYLE 17: PIN 1. VCC 2. V2OUT V10UT З. TXE 4. 5. RXE 6. VFF 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3 CATHODE 3 CATHODE 4 4. 5. CATHODE 5 6. COMMON ANODE COMMON ANODE 7. 8. CATHODE 6 STYLE 25: PIN 1. VIN 2 N/C REXT З. 4. GND 5. IOUT IOUT 6. IOUT 7. 8. IOUT STYLE 29: BASE, DIE #1 PIN 1. 2 EMITTER, #1 BASE, #2 З. EMITTER, #2 4. 5 COLLECTOR, #2 COLLECTOR, #2 6.

STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 COLLECTOR, #2 3. 4 COLLECTOR, #2 BASE, #2 5. EMITTER, #2 6. 7 BASE #1 EMITTER, #1 8. STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN SOURCE 4. SOURCE 5. 6. GATE GATE 7. 8. SOURCE STYLE 10: GROUND PIN 1. BIAS 1 OUTPUT 2. З. GROUND 4. 5. GROUND 6 BIAS 2 INPUT 7. 8. GROUND STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3 P-SOURCE P-GATE 4. P-DRAIN 5 6. P-DRAIN N-DRAIN 7. N-DRAIN 8. STYLE 18: PIN 1. ANODE ANODE 2. SOURCE 3. GATE 4. 5. DRAIN 6 DRAIN CATHODE 7. CATHODE 8. STYLE 22 PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3 COMMON CATHODE/VCC 4. I/O LINE 3 COMMON ANODE/GND 5. 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND STYLE 26: PIN 1. GND 2 dv/dt З. ENABLE 4. ILIMIT 5. SOURCE SOURCE 6. SOURCE 7. 8. VCC STYLE 30: DRAIN 1 PIN 1. DRAIN 1 2 GATE 2 З. SOURCE 2 4 SOURCE 1/DRAIN 2 SOURCE 1/DRAIN 2 5.

6.

7.

8 GATE 1

SOURCE 1/DRAIN 2

STYLE 3: PIN 1. DRAIN, DIE #1 DRAIN, #1 2. DRAIN, #2 З. DRAIN, #2 4. GATE, #2 5. SOURCE, #2 6. 7 GATE #1 8. SOURCE, #1 STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS THIRD STAGE SOURCE GROUND З. 4. 5. DRAIN 6. GATE 3 SECOND STAGE Vd 7. FIRST STAGE Vd 8. STYLE 11: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. З. GATE 2 4. 5. DRAIN 2 6. DRAIN 2 DRAIN 1 7. 8. DRAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 ANODE 1 3 ANODE 1 4. 5. CATHODE, COMMON CATHODE, COMMON CATHODE, COMMON 6. 7. CATHODE, COMMON 8. STYLE 19: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. 3. GATE 2 4. 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 MIRROR 1 8. STYLE 23: PIN 1. LINE 1 IN COMMON ANODE/GND COMMON ANODE/GND 2. 3 LINE 2 IN 4. LINE 2 OUT 5. COMMON ANODE/GND COMMON ANODE/GND 6. 7. 8. LINE 1 OUT STYLE 27: PIN 1. ILIMIT OVI O 2 UVLO З. 4. INPUT+ 5. 6. SOURCE SOURCE SOURCE 7. 8 DRAIN

DATE 16 FEB 2011

STYLE 4: PIN 1. 2. ANODE ANODE ANODE З. 4. ANODE ANODE 5. 6. ANODE 7 ANODE COMMON CATHODE 8. STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 З. BASE #2 COLLECTOR, #2 4. COLLECTOR, #2 5. 6. EMITTER, #2 EMITTER, #1 7. 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE SOURCE 2. 3. GATE 4. 5. DRAIN 6 DRAIN DRAIN 7. 8. DRAIN STYLE 16 EMITTER, DIE #1 PIN 1. 2. BASE, DIE #1 EMITTER, DIE #2 3 BASE, DIE #2 4. 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 COLLECTOR, DIE #1 7. COLLECTOR, DIE #1 8. STYLE 20: PIN 1. SOURCE (N) GATE (N) SOURCE (P) 2. 3. 4. GATE (P) 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 24: PIN 1. BASE EMITTER 2. 3 COLLECTOR/ANODE COLLECTOR/ANODE 4. 5. CATHODE 6. CATHODE COLLECTOR/ANODE 7. 8. COLLECTOR/ANODE STYLE 28: PIN 1. SW_TO_GND 2. DASIC OFF DASIC_SW_DET З. 4. GND 5. 6. V MON VBULK 7. VBULK 8 VIN

DOCUMENT NUMBER:	98ASB42564B	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	SOIC-8 NB		PAGE 2 OF 2	

onsem and of isor in are trademarks or semiconductor compension instructions, the do onsem or its subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced states and/or outrofts, or non-emitting the subsidiaries in the oniced stat purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

7.

8

COLLECTOR, #1

COLLECTOR, #1

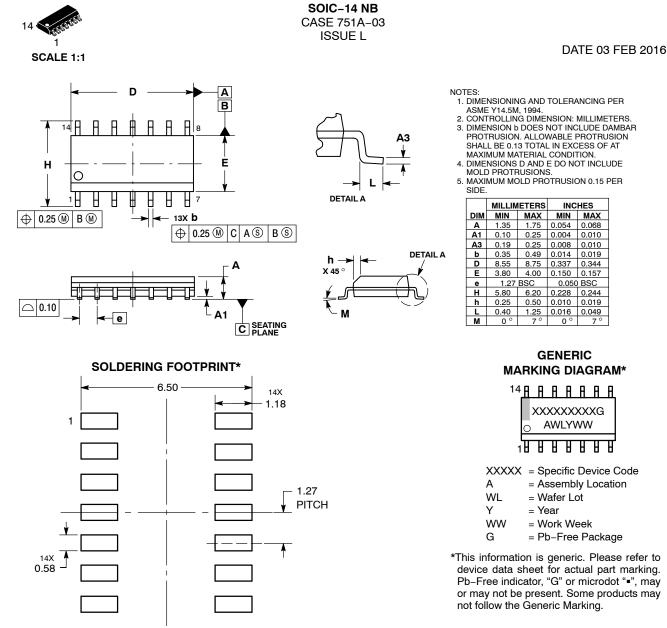
DUSEM

0.068

0.019

0.344

0.244



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

STYLES ON PAGE 2

Electronic versions are uncontrolled except when accessed directly from the Document Repository. DOCUMENT NUMBER: 98ASB42565B Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DESCRIPTION:** SOIC-14 NB PAGE 1 OF 2 onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

SOIC-14 CASE 751A-03 ISSUE L

DATE 03 FEB 2016

STYLE 1: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. NO CONNECTION 5. ANODE/CATHODE 6. NO CONNECTION 7. ANODE/CATHODE 8. ANODE/CATHODE 9. ANODE/CATHODE 10. NO CONNECTION 11. ANODE/CATHODE 12. ANODE/CATHODE 13. NO CONNECTION 14. COMMON ANODE	STYLE 2: CANCELLED	STYLE 3: PIN 1. NO CONNECTION 2. ANODE 3. ANODE 4. NO CONNECTION 5. ANODE 6. NO CONNECTION 7. ANODE 8. ANODE 9. ANODE 10. NO CONNECTION 11. ANODE 12. ANODE 13. NO CONNECTION 14. COMMON CATHODE	STYLE 4: PIN 1. NO CONNECTION 2. CATHODE 3. CATHODE 4. NO CONNECTION 5. CATHODE 6. NO CONNECTION 7. CATHODE 8. CATHODE 10. NO CONNECTION 11. CATHODE 12. CATHODE 13. NO CONNECTION 14. COMMON ANODE
STYLE 5: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. ANODE/CATHODE 5. ANODE/CATHODE 6. NO CONNECTION 7. COMMON ANODE 8. COMMON CATHODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. ANODE/CATHODE 12. ANODE/CATHODE 13. NO CONNECTION 14. COMMON ANODE	STYLE 6: PIN 1. CATHODE 2. CATHODE 3. CATHODE 4. CATHODE 5. CATHODE 6. CATHODE 7. CATHODE 8. ANODE 9. ANODE 10. ANODE 11. ANODE 12. ANODE 13. ANODE 14. ANODE	STYLE 7: PIN 1. ANODE/CATHODE 2. COMMON ANODE 3. COMMON CATHODE 4. ANODE/CATHODE 5. ANODE/CATHODE 6. ANODE/CATHODE 7. ANODE/CATHODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. COMMON CATHODE 12. COMMON CATHODE 13. ANODE/CATHODE 14. ANODE/CATHODE	STYLE 8: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. NO CONNECTION 5. ANODE/CATHODE 6. ANODE/CATHODE 7. COMMON ANODE 8. COMMON ANODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. NO CONNECTION 12. ANODE/CATHODE 13. ANODE/CATHODE 14. COMMON CATHODE

DOCUMENT NUMBER:	98ASB42565B	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	SOIC-14 NB		PAGE 2 OF 2	

onsemi and ONSEMI: are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and calcular performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

TECHNICAL SUPPORT

onsemi Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative